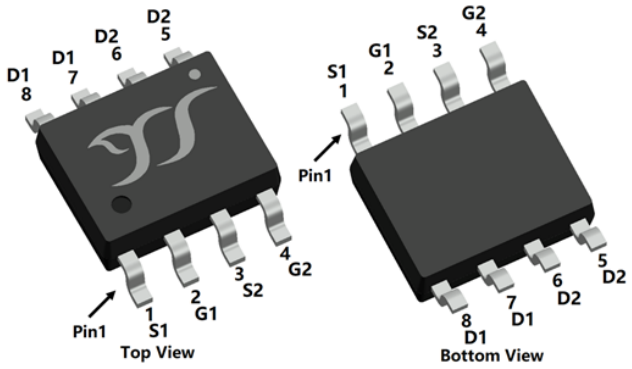
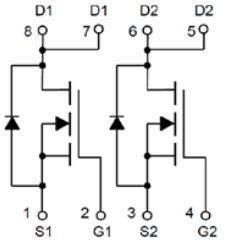
N-Channel and N-Channel Complementary MOSFET



SOP-8



Product Summary

- V_{DS} 30V
- I_D 6.5A
- $R_{DS(ON)}$(at V_{GS}=10V) ＜20mΩ
- $R_{DS(ON)}$(at V_{GS}=4.5V) ＜41mΩ

General Description

- Trench Power LV MOSFET technology
- High density cell design for low RDS(ON)
- High Speed switching
- Moisture Sensitivity Level 3
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free

Applications

- Battery protection
- Load switch
- Power management

■ Absolute Maximum Ratings (T_A=25℃ unless otherwise noted)

Parameter			Symbol	Limit	Unit
Drain-source Voltage			V_{DS}	30	V
Gate-source Voltage			V_{GS}	±20	V
Drain Current	Steady-State	T_A=25℃	I_D	6.5	A
		T_A=100℃		4.1	
	t<10s	T_A=25℃		8.5	
		T_A=100℃		5.3	
Pulsed Drain Current [A]			I_{DM}	50	A
Total Power Dissipation [B]	Steady-State	T_A=25℃	P_D	1.25	W
		T_A=100℃		0.5	
	t<10s	T_A=25℃		1.92	
		T_A=100℃		0.76	
Junction and Storage Temperature Range			T_J ,T_{STG}	-55～+150	℃

■Thermal resistance

Parameter		Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient [C]	Steady-State	$R_{\theta JA}$	80	100	℃/W
	t<10s		55	65	

■ Ordering Information (Example)

PREFERED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJS3404B	F2	Q3404B.	4000	8000	64000	13“ reel

■ Electrical Characteristics (T_J=25℃ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS}= 0V, I_D=250μA	30	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS}=30V, V_{GS}=0V	-	-	1	μA
		V_{DS}=30V, V_{GS}=0V, Tj=150℃	-	-	100	
Gate-Body Leakage Current	I_{GSS}	V_{GS}= ±20V, V_{DS}=0V	-	-	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS}= V_{GS}, I_D=250μA	1	1.5	2.2	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	V_{GS}=10V, I_D=6.5A	-	15.5	20	mΩ
		V_{GS}=4.5V, I_D=6A	-	30	41	
Diode Forward Voltage	V_{SD}	I_S=6.5A, V_{GS}=0V	-	-	1.2	V
Gate resistance	R_G	f=1MHz	-	3	-	Ω
Maximum Body-Diode Continuous Current	I_S		-	-	6.5	A
Dynamic Parameters						
Input Capacitance	C_{iss}	V_{DS}=15V, V_{GS}=0V, f=1MHz	-	390	-	pF
Output Capacitance	C_{oss}		-	70	-	
Reverse Transfer Capacitance	C_{rss}		-	55	-	
Switching Parameters						
Total Gate Charge	Q_g	V_{GS}=10V, V_{DS}=15V, I_D=5.6A	-	8.3	-	nC
Gate-Source Charge	Q_{gs}		-	1.5	-	
Gate-Drain Charge	Q_{gd}		-	2.5	-	
Reverse Recovery Charge	Q_{rr}	I_F=5.6A, di/dt=175A/us	-	6	-	nC
Reverse Recovery Time	t_{rr}		-	9	-	ns
Turn-on Delay Time	$t_{D(on)}$	V_{GS}=10V, V_{DD}=15V, I_D=5.6A R_{GEN}=2.2Ω	-	5	-	ns
Turn-on Rise Time	t_r		-	31	-	
Turn-off Delay Time	$t_{D(off)}$		-	13	-	
Turn-off fall Time	t_f		-	3	-	

A. Repetitive rating; pulse width limited by max. junction temperature.
B. P_d is based on max. junction temperature, using junction-ambient thermal resistance.
C. The value of $R_{\theta JA}$ is measured with the device mounted on the minimum recommend pad size, in the still air environment with T_A =25℃. The maximum allowed junction temperature of 150℃. The value in any given application depends on the user's specific board design.

■Typical Electrical and Thermal Characteristics Diagrams

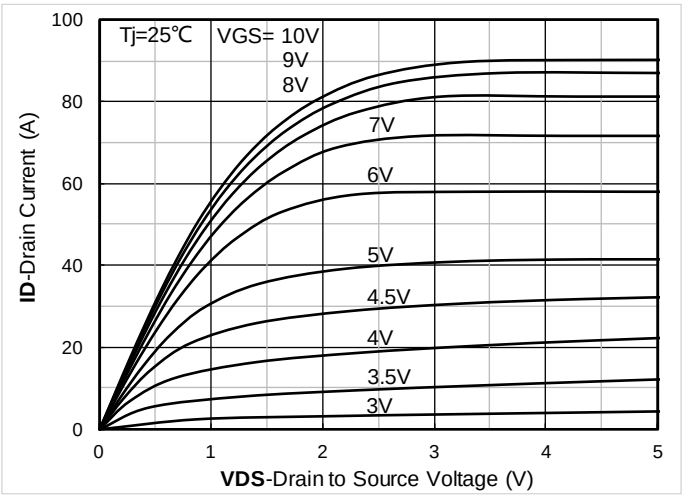


Figure 1. Output Characteristics

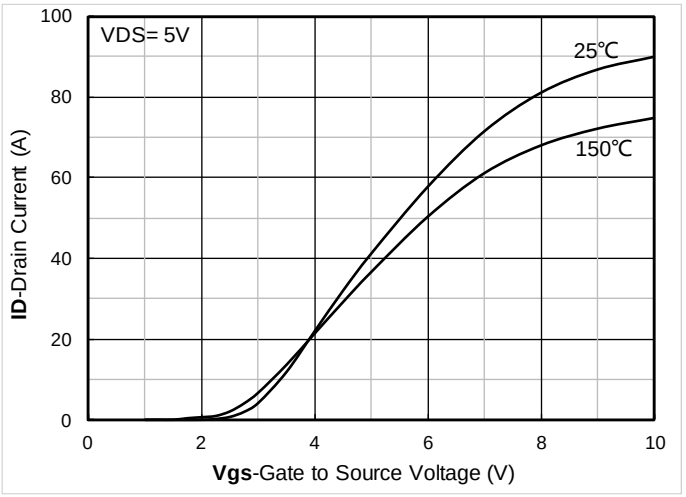


Figure 2. Transfer Characteristics

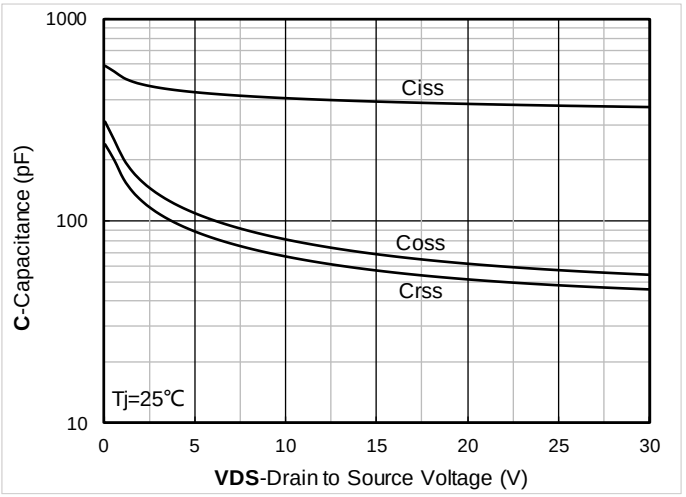


Figure 3. Capacitance Characteristics

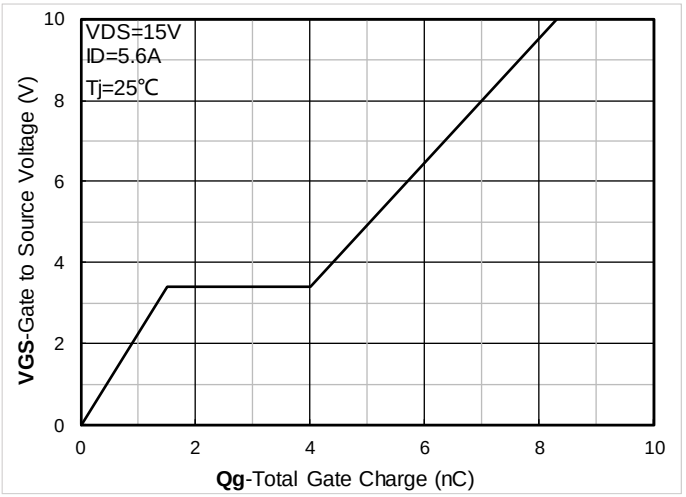


Figure 4. Gate Charge

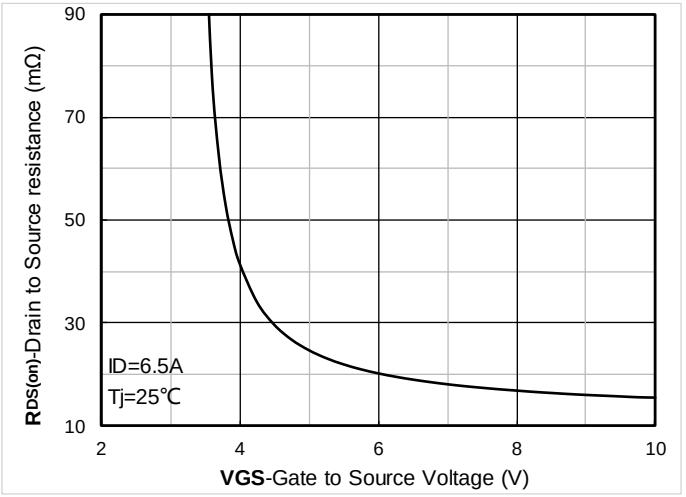


Figure 5. On-Resistance vs Gate to Source Voltage

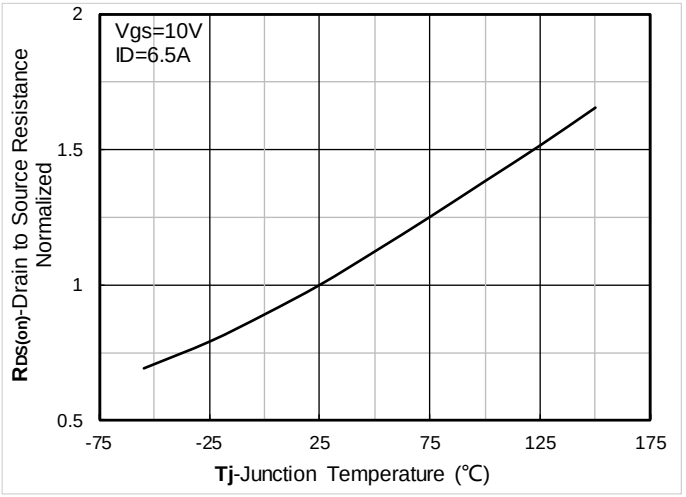


Figure 6. Normalized On-Resistance

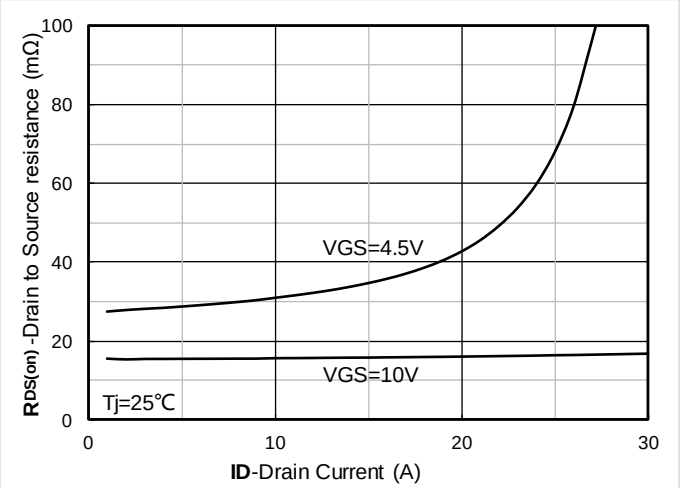


Figure 7. $R_{DS(on)}$ VS Drain Current

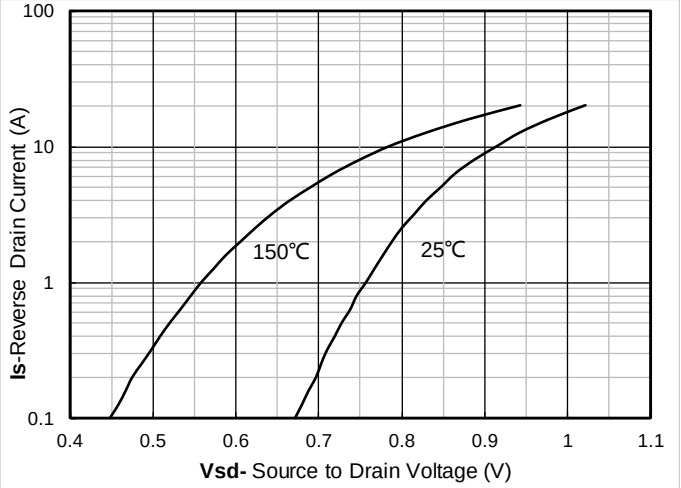


Figure 8. Forward characteristics of reverse diode

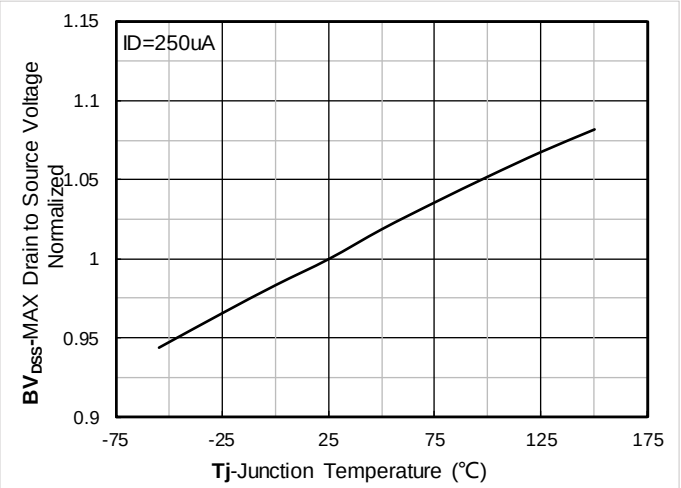


Figure 9. Normalized breakdown voltage

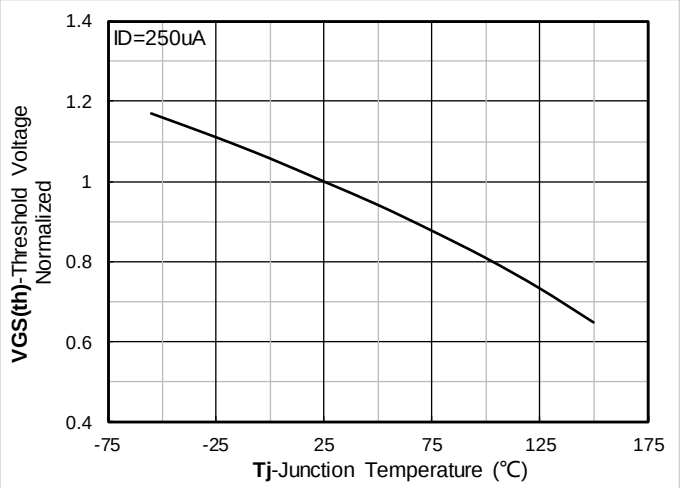


Figure 10. Normalized Threshold voltage

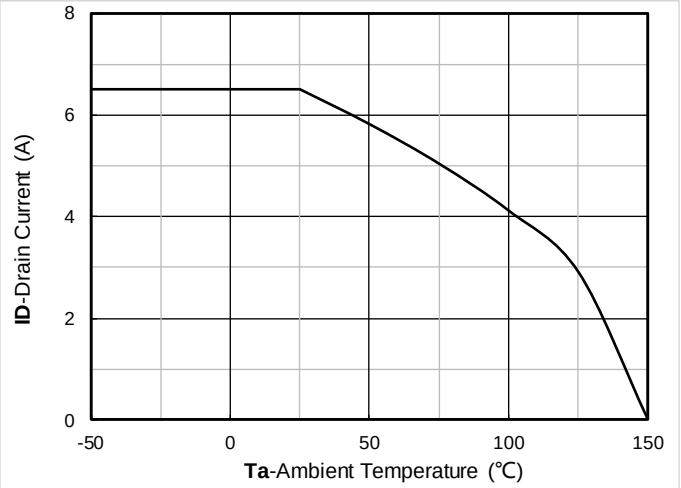


Figure 11. Current dissipation

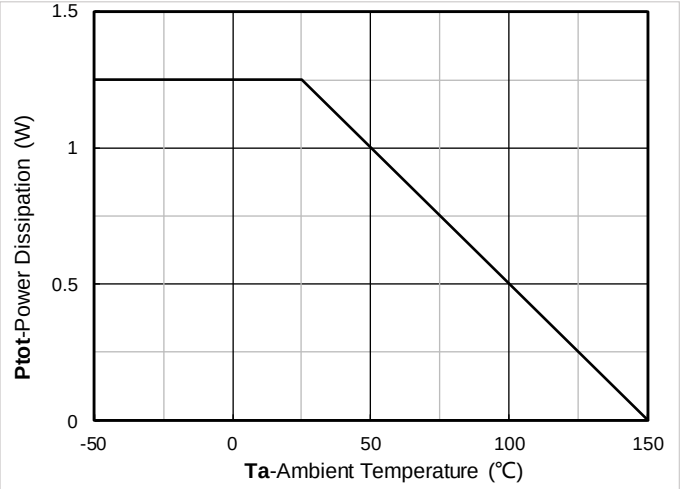


Figure 12. Power dissipation

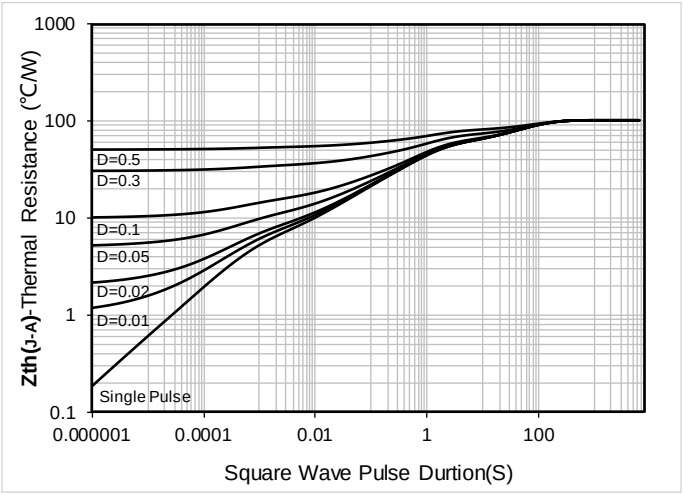


Figure 13. Maximum Transient Thermal Impedance

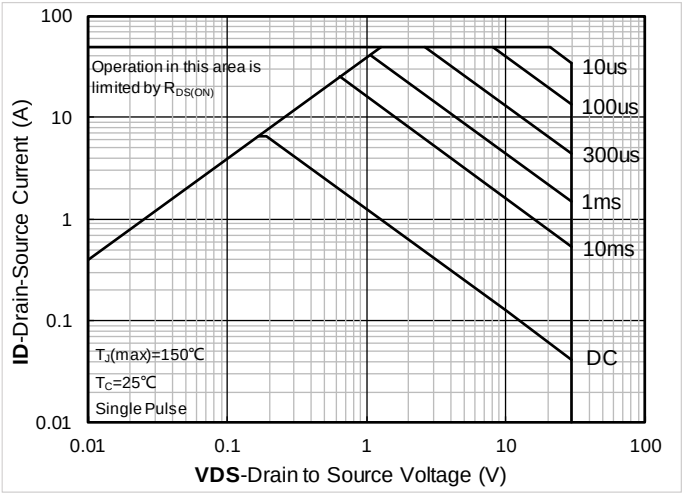


Figure 14. Safe Operation Area

■ Test Circuits & Waveforms

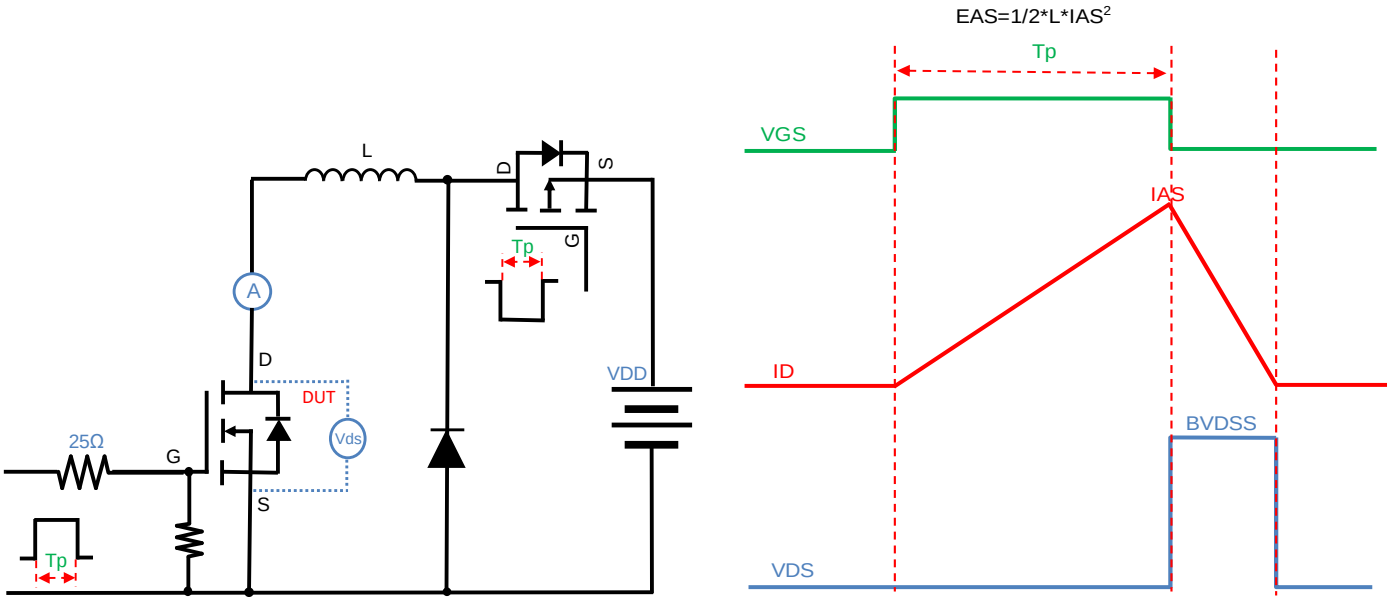


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform

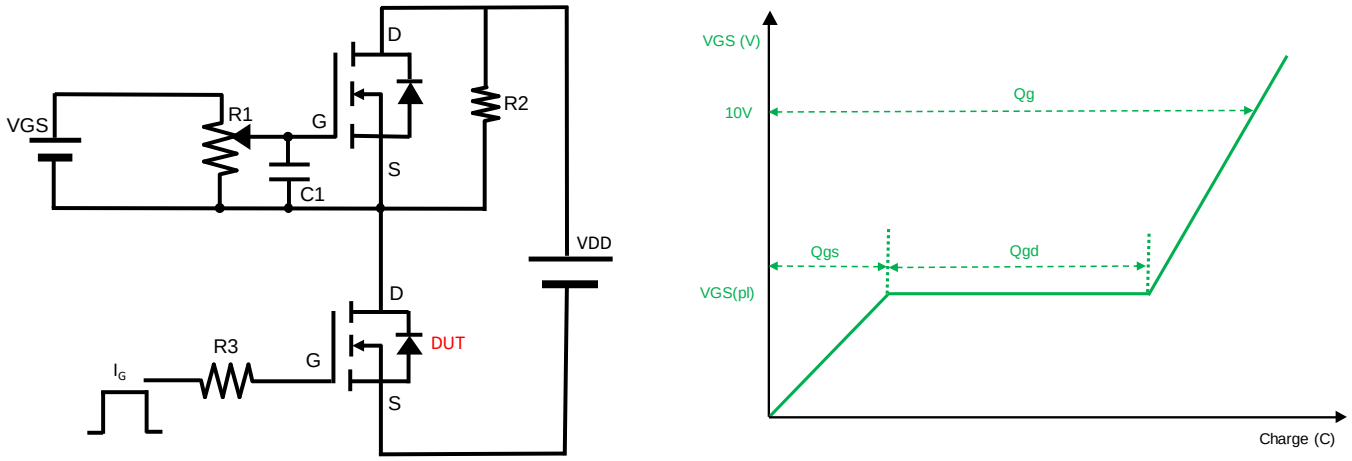


Figure B. Gate Charge Test Circuit & Waveform

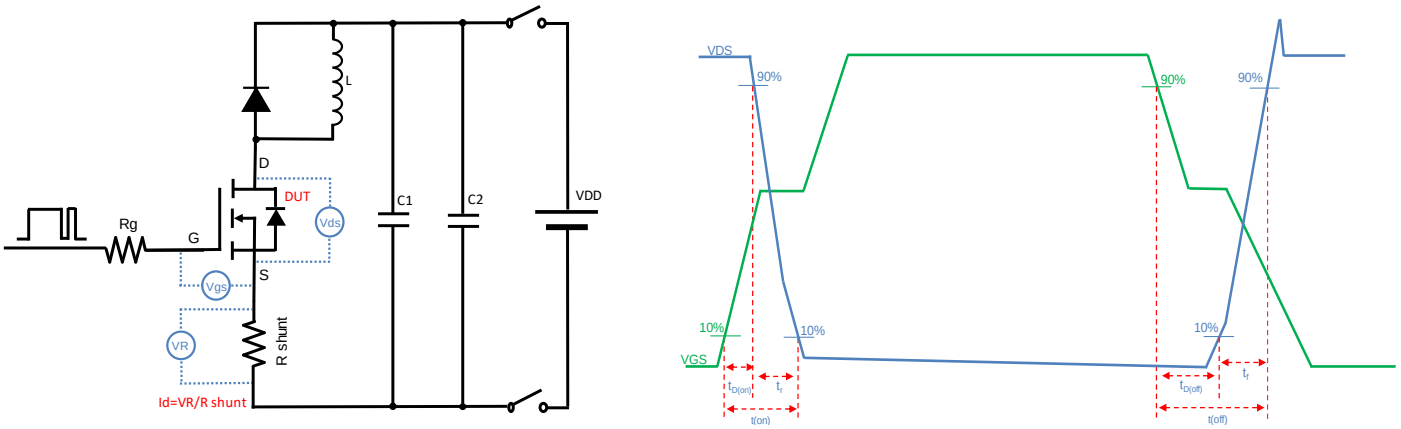


Figure C. Resistive Switching Test Circuit & Waveform

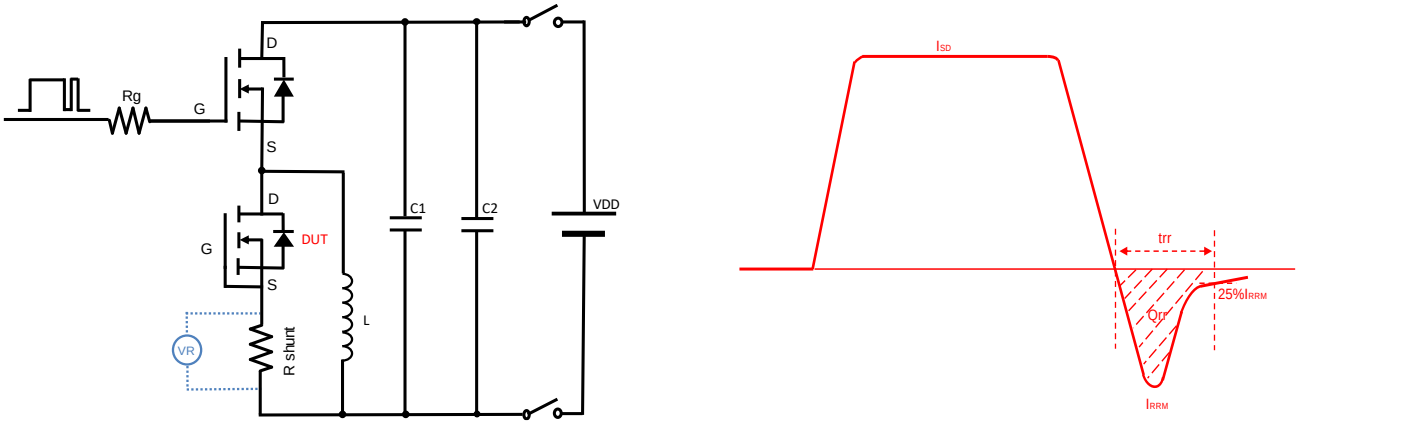
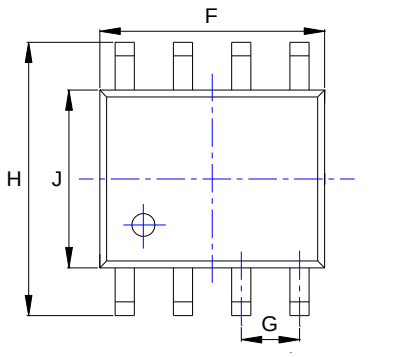
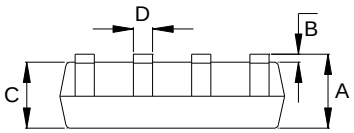


Figure D. Diode Recovery Test Circuit & Waveform

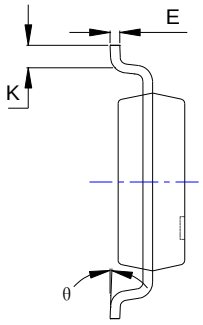
■ SOP-8 Package information



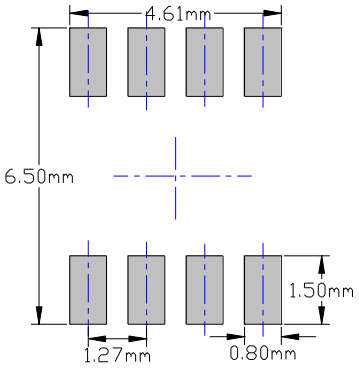
TOP VIEW



SIDE VIEW



SIDE VIEW



Suggested Solder Pad Layout

DIMENSIONS				
SYMBOL	INCHES		Millimeter	
	MIN.	MAX.	MIN.	MAX.
A	0.053	0.069	1.350	1.750
B	0.004	0.010	0.100	0.250
C	0.053	0.061	1.350	1.550
D	0.013	0.020	0.330	0.510
E	0.007	0.010	0.170	0.250
F	0.189	0.197	4.800	5.000
G	0.050BSC		1.270BSC	
H	0.228	0.244	5.800	6.200
J	0.150	0.157	3.800	4.000
K	0.016	0.050	0.400	1.270
θ	0°	8°	0°	8°

Note:
1.Controlling dimension:in millimeters.
2.General tolerance:+/-0.05mm.
3.The pad layout is for reference purposes only.

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